

PRODUCT DATASHEET

Gas Discharge Tubes





Applications

- Communication equipment
- CATV equipment
- Test equipment
- Data lines
- Power supplies
- Telecom SLIC protection
- Telecommunications

Description -

Gas discharge tubes (GDT) use noble gasses enclosed in ceramic tubes to provide an alternate circuit path for voltage spikes. The ceramic envelope and with nickel connectors allow for high loads. The breakdown voltages of the devices have a wide range (up to 20% olerance). Major applications are high requency telecommunication lines, stations, security systems, HID and high quality Surge Protection Devices.

Features -

- RoHS & HF compliant
- Low Capacitance
- Micro-Gap Design
- Stable breakdown voltage
- · High insulation resistance
- High holdover voltage
- · Large absorbing transient current capability

Electriacl Characteristics

Part No.	DC Spark-over Voltage 100V/S(V)	Max.Impulse Spark-over Voltage 1KV/µs(V)	Nominal Discharge Current(L) 1s,50Hz(A)	Nominal Impulse Discharge Current 8x20µs(kA)	Insulation Resistance min. (GΩ)/ (Vdc)	Max. Capacitance C 1MHz(pF)
JTS5050-075	75±30%	650	5	5	1GΩ/50Vdc	1
JTS5050-090	90±30%	600	5	5	1GΩ/50Vdc	1
JTS5050-150	150±20%	600	5	5	1GΩ/50Vdc	1
JTS5050-230	230±20%	700	5	5	1GΩ/100Vdc	1
JTS5050-400	400±20%	1000	5	5	1GΩ/100Vdc	1
JTS5050-470	470±20%	1200	5	5	1GΩ/100Vdc	1
JTS5050-600	600±20%	1200	5	5	1GΩ/250Vdc	1
JTS5050-800	800±20%	1400	5	5	1GΩ/250Vdc	1
JTS5050-1000	1000±20%	1800	5	5	1GΩ/250Vdc	1
JTS5050-1200	1200±20%	2000	5	5	1GΩ/500Vdc	1
JTS5050-2000	2000±20%	3800	5	5	1GΩ/500Vdc	1



Electrical Performance

Item	Testing condition and method	Performance
DC Spark-over Voltage(Vs)	Measure starting discharge voltage (Vs) by gradualy increasing applied DC voltage. Test current is 1mA max. and test period is 1 second max. and the DC voltage ascend up within 100v/second.	Meet specified value
Insulation	Measure the insulation resistance across the terminal at regulated voltage But The test voltage doesn't over the DC spark-over voltage with 50Vdc/100Vdc/250Vdc/500Vdc.	1G Ω or over
Resistance(IR) Capacitance	Measure the electrostatic capacitance by applying a voltage of less than 6V(at 1MHz) between terminals.	1pF or less

The testing condition shall be subject to the following items:

- 1. Ambient Temp.:-40°C~125°C; Relative Humidity:<95%(40°CH);
- 2. Atmospheric Pressure 8.6×10⁴Pa~1.06×10⁴Pa.

Physical and Solderability Characteristics

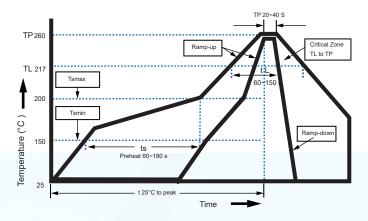
Item	Testing condition and method	Performance
	Specimens shall be soldered to testing board. The substrate shall be supported	No evidence of
Bending	at two points 45 mm from its center with mounting surface, and the middle part	mechanical damage ,
strength	of its board shall be pressed at rate of 1.0 mm per second until the deflection	Meet specified value.
	becomes 3 mm and then the pressure shall be maintained for 30 seconds.	
Terminal	Specimens shall be soldered to testing board. Then apply force in parallel	No evidence of
Strength	- 2 kg 30 second hanging.	mechanical damage
		,Meet specified value.
	After dipping the lead wire to a depth of 2mm from the body in a soldering bath	Over 95% of the lead
Solderability	of 260±5°C for 10±1 sec.	wire should be covered
		with new solder.
Resistance to	After dipping the lead wire to a depth of 2mm from the body in a soldering bath	Meet DC spark-over
soldering heat	of 260±5°C for 10±1 sec.	voltage tolerance.



Environmental Characteristics

Item	Testing condition and method						Performance	
Resistance	The specimen shall be subjected to - 55±3°C for 1000 hours without load and						Meet specified value.	
to cold	then stored	at room tem	perature and	d humidity for	4 hours.			•
Resistance	The specin	nen shall be s	subjected to	125±2°C for	1000 hours v	vithout load an	ıd	Meet specified value.
to heat	then stored	l at room tem	perature and	d humidity for	4 hours.			moor opcomed value.
Resistance	The specin	nen shall be s	subjected to	85±2°C 85%I	R.H.for 1000	hours without		Meet specified value.
to humidity	load and th	en stored at	room tempe	rature and hu	midity for 4 h	nours.		
Surge life	Apply a impulse current (8/20µs of 3KA/5KA) (a+b-E)for 10 times at 60 seconds intervals, Thereafter, the characteristics of times Vs,IR and C shall be measured (EN61000-4-5).						No cracks or failures after applying current	
	Repeat the temperature cycle shown below 200 times then store parts at room temperature and humidity for 4 hours:					om		
Heat cycle		Step	1	2	3	4		M t : C l l
		Temperature	-55±3°C	Room Temp	125±2°C	Room Temp		Meet specified value
		Perild	30min	30min	30min	30min		
Temperature	Operating temp range :-55°C to +125°C							
range	Storage ter	mp range :-40)°C to +85°C	;				

Soldering Parameters



- Recommended reflow methods: IR, vapor phase oven, hot air oven, N2 environment for lead-free.
- Recommended maximum paste thickness is 0.25mm Devices can be cleaned using standard industry methods and solvents.
- Note 1:All temperature refer to topside of the package, measured on the package body surface.
- Note 2: If reflow temperatures exceed the recommended profile, devices may not meet the performance requirements.

Profile Feature	Pb-Free Assembly
Average Ramp-Up Rate	3°C/second mac.
(Ts max to T p)	
Preheat	
-Temperature Min(Ts min)	150°C
-Temperature Max(Ts max)	200°C
-Time(Ts min to Ts max)	60~180 seconds
Time maintained above:	
-Temperature(TL)	217°C
-Time(tL)	60~150 seconds
Peak Temperature(Tp)	260°C
Ramp-Down Rate	6°C/second max.
Time 25°C to Peak Temperatu	re 8 minutes max

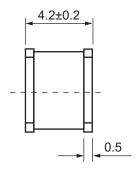
Storage And Handling:

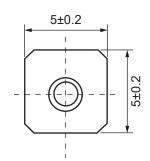
Storage conditions 0°C~35°C,30%~60%R.H.

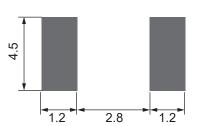
Devices may not meet specified performance if storage conditions are exceeded.



Dimensions and Structure (mm) -



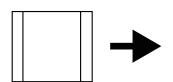


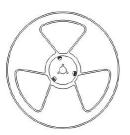


Recommended Land Pattern

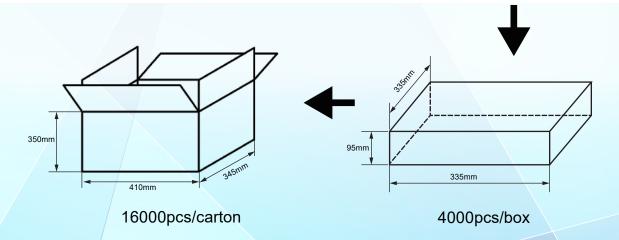
Packaging

No.	Quantity &Packaging Code
JTS5050	1000 pcs/reel



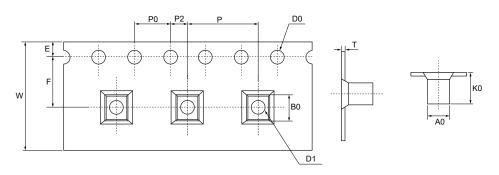


1000pcs/reel

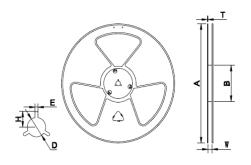




Tape And Reel Specifications (mm)



Item	w	A0	во	K0	E	F
Spec.(mm)	16.00 +0.30 -0.10	5.40±0.10	4.60±0.1	5.30±0.1	1.75±0.1	7.5±0.1
Item	P	P0	P2	D0	D1	т
Spec.(mm)	12.00±0.1	4.00±0.1	2.00±0.1	1.50 ^{+0.1}	1.50 ^{+0.1}	0.40±0.05



Item	A	В	D	
Spec.(mm)	330±1	99.5±2	13±0.5	
Item	E	н	w	Т
Spec.(mm)	2.2±0.5	11±1	16.5±0.4	2.2±0.2

Part Number System

